

# n-channel silicon JFET

**designed for . . .**



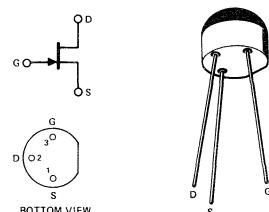
Performance Curves NH  
See Section 4

## ■ VHF Amplifiers ■ Mixers

### ABSOLUTE MAXIMUM RATINGS (25°C)

Gate-Drain or Gate-Source Voltage	.....	-30 V
Forward Gate Current	.....	10 mA
Total Continuous Device Dissipation at (or Below) TA = 25°C	.....	
(Derate 3.5 mW/°C to 125°C)	.....	350 mW
Storage Temperature Range	.....	-55 to +125°C
Lead Temperature (1/16" from case for 10 seconds)	.....	300°C

TO-106  
See Section 5



### ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

Characteristic			Min	Max	Unit	Test Conditions			
1 S T A T I C 6	IGSS	Gate Reverse Current		-100	pA	VGS = -20 V, VDS = 0	TA = 100°C		
				-10	nA				
2 Y N 9 M 11	BVGSS	Gate-Source Breakdown Voltage	-30		V	Ig = 1 μA, VDS = 0			
3 I T C I C	VGS(off)	Gate-Source Cutoff Voltage		-6	V	VDS = 15 V, ID = 1 nA			
4 I C I C	VGS	Gate-Source Voltage	-1.0	-5.5	V	VDS = 15 V, ID = 500 μA			
5 I DSS	Saturation Drain Current (Note 1)		5	15	mA	VDS = 15 V, VGS = 0			
7 D Y N 9 M 11	gfs	Common-Source Forward Transconductance (Note 1)	4500	7500	μmho	VDS = 15 V, VGS = 0	f = 1 kHz		
8 I C I C	gos	Common-Source Output Conductance		50	μmho				
9 A C I C	Crss	Common-Source Reverse Transfer Capacitance		1	pF				
10 I C I C	Ciss	Common-Source Input Capacitance		4	pF				
11 C Coss	Common-Source Output Capacitance			2		f = 1 MHz			
Characteristic			100 MHz		400 MHz		Unit		
			Min	Max	Min	Max	Unit		
12 H I F E Q	giss	Common-Source Input Conductance	100		1000		μmho	VDS = 15 V, VGS = 0	
13 I R F E Q	biss	Common-Source Input Susceptance	2500		10,000		μmho		
14 I R F E Q	goss	Common-Source Output Conductance		75		100	μmho		
15 R F E Q	boss	Common-Source Output Susceptance	1000		4000		μmho		
16 E Q	gfs	Common-Source Forward Transconductance (Note 1)		4000			μmho		
17 G P S	Gps	Common-Source Power Gain	18		10		dB	VDS = 15 V, ID = 5 mA	
18	NF	Noise Figure		2		4	dB	VDS = 15 V, ID = 5 mA, RG = 1 KΩ	

NOTE:

1. Pulse test duration = 300 μs.

NH